

Estimating mutual information using sparse regression

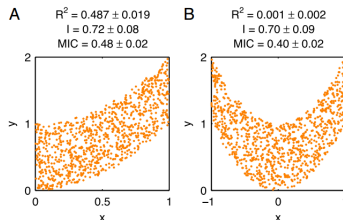
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(Joint work with Yuval Benjamini.)

Mutual information (Shannon 1948)



- $I(X; Y) \in [0, \infty]$. (0 if $X \perp Y$, ∞ if $X = Y$ and X continuous.)
- Symmetry: $I(X; Y) = I(Y; X)$.
- Data-processing inequality

$$I(X; Y) \geq I(\phi(X); \psi(Y))$$

equality for ϕ, ψ bijections

Image credit Kinney et al. 2014.

Applications of $I(X; Y)$

- Feature selection (Peng et al. 2005, Fleuret 2004, Bennesar et al. 2015)
- Structure learning for graphical models using conditional mutual information $I(X; Y|Z)$ (Vastano and Swinney 1988, Cheng et al. 1997, Bach and Jordan 2002)
- Quantifying information capacity of neurons

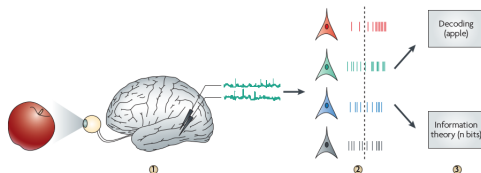


Image credits: Quiroga et al. (2009).

How to estimate $I(X; Y)$

Suppose we observe pairs $(X_i, Y_i)_{i=1}^n$ iid from density $p(x, y)$

- Definition of mutual information:

$$I(X; Y) = \int \log \left(\frac{p(x, y)}{p(x)p(y)} \right) p(x, y) dx dy$$

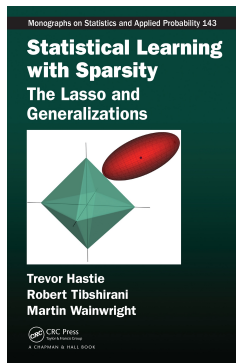
- Simply using plugging in kernel density estimate $\hat{p}(x, y)$ leads to large bias (Beirlant et al. 2001)
- Jackknifed estimate gives better result (Ivanov and Rozhkova 1981)

$$\hat{I}(X; Y) = \frac{1}{n} \sum_{i=1}^n \log \left(\frac{\hat{p}_{-i}(x_i, y_i)}{\hat{p}_{-i}(x_i) \hat{p}_{-i}(y_i)} \right)$$

Problems in high dimensions

- Density estimation is known to have exponential complexity with respect to dimensionality.
- Many applications with high-dimensional X , Y .
 - Gene expression time series
 - Functional magnetic resonance imaging
- One approach is to assume joint multivariate normality of X , Y , but this reduces mutual information to a linear statistic.
- Other approaches: binning (Bialek et al. 1991, Paninski 2003), confusion matrix of a classifier (Treves 1997, Quiroga et al. 2009).

Idea: Use sparsity!



- Suppose that $Y \approx f(X) + \epsilon$, where f depends *sparsely* on X .
- Can we exploit the sparsity to obtain an estimate of $I(X; Y)$?

Our proposal

Suppose we observe pairs $(X_i, Y_i)_{i=1}^n$ iid from density $p(x, y)$.

- 1 Estimate a (sparse) regression model for $\mathbf{E}[y|x]$.
- 2 Estimate the noise model for Y .
- 3 Estimate the *identification risk* p using cross-validation.
- 4 Use the identification risk to obtain a lower bound for the mutual information $I(X; Y)$:

$$I(X; Y) \geq f(p)$$

where f is a function that we derive theoretically.

Multiple-response regression

- Pairs $(x_i, y_i)_{i=1}^n$, where X is p -dimensional and Y is q -dimensional.
- Data matrices $\mathbf{X}_{n \times p}$, $\mathbf{Y}_{n \times q}$.
- For each column of Y , fit sparse model $Y^{(i)} \approx X^T \beta^{(i)} + \epsilon$, e.g. by using elastic net (Zou 1998),

$$\hat{\beta}^{(i)} = \operatorname{argmin}_{\beta} \|\mathbf{X}^T \beta^{(i)} - Y^{(i)}\|^2 + \lambda_2 \|\beta^{(i)}\|_2^2 + \lambda_1 \|\beta^{(i)}\|_1$$

Regression vs Identification loss

- Independent *test set* $(x_i^*, y_i^*)_{i=1}^k$.
- Use model to predict $\hat{y}_i^* = (x_i^*)^T \hat{B}$ for $i = 1, \dots, k$.

Two ways to evaluate the predictive accuracy of the regression model:

- Regression (mean squared-error) loss:

$$\text{MSE} = \frac{1}{k} \sum_{i=1}^k \|y_i^* - \hat{y}_i^*\|^2.$$

- Identification loss:

$$\text{IdLoss}_k = \frac{1}{k} \sum_{i=1}^k (1 - I\{\hat{y}_i^* \text{ is nearest neighbor of } y_i^*\}).$$

Leave- k -out cross-validation (LkoCV) can be used for both squared-error loss and identification loss.

- Start with a dataset $(x_i, y_i)_{i=1}^N$.
- Let $n = N - k$. Consider all $\binom{N}{k}$ partitions of the dataset into a test set (\mathbf{X}, \mathbf{Y}) and training set $(\mathbf{X}^*, \mathbf{Y}^*)$.
- For each partition, compute the loss.
- Define the LkoCV loss as the average loss over $\binom{N}{k}$ partitions.

Computational note. One can subsample to avoid computing all $\binom{N}{k}$ partitions. In particular, if $m = N/k$, then one can use m -fold cross-validation which uses m partitions that have disjoint test sets.

Identification loss and mutual information

- Define the identification risk as the expected identification loss

$$\text{IdRisk}_k = \mathbf{E}[\text{IdLoss}_k]$$

- Define the Bayes risk as the identification risk given the *true* model parameters. Hence,

$$\text{BayesRisk}_k \leq \text{IdRisk}_k.$$

- Theorem.** (Z., Benjamini 2016) There exists a function g_k such that

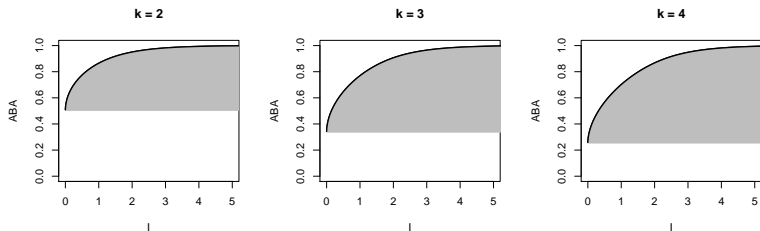
$$I(X; Y) \geq g_k(\text{IdRisk}_k).$$

- Resulting estimator:

$$\hat{I}_{\text{IdLoss}}(X; Y) = g_k(\text{IdLoss}_k).$$

Functions

Illustration of $C_k = g_k^{-1}$



As information increases, the maximal identification risk goes to 0. [note: pictures need to be rotated]